

RF EXPOSURE REPORT

On Behalf of

Amiigo Inc.

Wavelet Charger

Model No.: C1001

FCC ID: 2AKLD-C1001

Prepared for : Amiigo Inc.

Address

465 Fairchild Drive, Suite 228 Mountain Veiw CA 94043,

USA

Prepared By : Shenzhen Alpha Product Testing Co., Ltd.

2B/F., Building B, No.99, East Area of Nanchang Second

Address : Industrial Zone, Gushu 2nd Road, Bao' an District, Shenzhen,

Guangdong, China

Report Number : T1862416 02

Date of Receipt : November 24, 2016 Date of Test : June 13- June 22, 2017

Date of Report : June 23, 2017

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TEST REPORT DECLARATION

Applicant : Amiigo Inc. Manufacturer Amiigo Inc.

EUT Description Wavelet Charger

> C1001 (A) Model No. Wavelet Trademark

DC 5V from USB port **Ratings Supply** (C)

DC 5V from USB port with AC 120V/60Hz (D) Test Voltage

Report No.: T1862416 02

Input

DC 5V, 0.5A (E) Rated Output

Measurement Standard Used:

FCC Rules and Regulations KDB680106

The device described above is tested by Shenzhen Alpha Product Testing Co., Ltd. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The test results are contained in this test report and Shenzhen Alpha Product Testing Co., Ltd. is assumed full responsibility for the accuracy and completeness of test. Also, this report shows that the EUT is technically compliant with the FCC KDB requirements.

This report applies to above tested sample only. This report shall not be reproduced in parts without written approval of Shenzhen Alpha Product Testing Co., Ltd.

Reak Yang Tested by (name + signature)....: **Test Engineer**

Reak Yang Simple Guan Approved by (name + signature).....: Project Manager

June 23, 2017 Date of issue....:

1. SUMMARY OF STANDARDS AND RESULTS

1.1.Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below:

EMISSION								
Description of Test Item Standard Results								
RF EXPOSURE	§1.1307(b)(1) & KDB680106	P						
Note: 1. P is an abbreviation for Pass. 2. F is an abbreviation for Fail.								
3. N/A is an abbrevia	tion for Not Applicable.							

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2. GENERAL INFORMATION

2.1.Description of Device (EUT)

Description : Wavelet Charger

Model Number : C1001 Diff : N/A Modulation Type : MSK

Operation

: 120-205KHz

Frequency

Antenna type

: Integrated Antenna

Antenna gain : 0dBi

Test Voltage : DC 5V from USB port with AC 120V/60Hz Input

Trademark : Wavelet

Applicant : Amiigo Inc.

Address : 465 Fairchild Drive, Suite 228 Mountain Veiw CA 94043, USA

Manufacturer : Amiigo Inc.

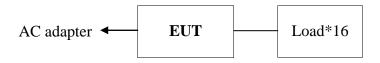
Address : 465 Fairchild Drive, Suite 228 Mountain Veiw CA 94043, USA

Sample Type : Prototype production

2.2.Tested Supporting System Details

No.	Description	Manufacturer	Model	Serial Number	Certification or DOC
1	Adapter	Wopow	A9-501000	N/A	VOC

2.3.Block Diagram of connection between EUT and simulators



	Signal Cable Description of the above Support Units											
No.	Port Name	Cable	Shielded (Yes or No)	Detachable (Yes or No)								
(a)	N/A	N/A	N/A	N/A	N/A							

EUT: Wavelet Charger

2.4.Test mode Description

No.	Test Mode							
1.	Full Load	3	Half Load for shoepod					
2	Half Load for wrist band	4	No Load					

2.5.Test Facility

Shenzhen Alpha Product Testing Co., Ltd.

2B/F., Building B, No.99, East Area of Nanchang Second Industrial Zone, Gushu 2nd Road, Bao' an District, Shenzhen, Guangdong, China

March 25, 2015 File on Federal Communication Commission

Registration Number: 203110

July 18, 2014 Certificated by IC Registration Number: 12135A

2.6. Measurement Uncertainty

(95% confidence levels, k=2)

Test Item	Uncertainty
Uncertainty for Conduction emission test	2.71dB
	3.90 dB (Distance:
Uncertainty for Radiation Emission test	3m Polarize: V)
(<1G)	3.92 dB (Distance:
	3m Polarize: H)
	4.26 dB (Distance:
Uncertainty for Radiation Emission	3m Polarize: V)
test(>1G)	4.28 dB (Distance:
	3m Polarize: H)

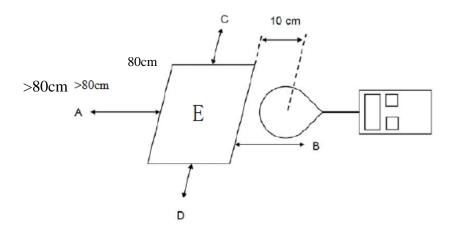
3. RF EXPOSURE TEST

3.1.Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Exposure	narda	ELT-400	N-0231	2016.09.29	1 Year
	Level Tester					
2.	Magnetic field	narda	ELT probe	M0675	2016.09.29	1 Year
	probe 100cm2		100cm2			

3.2.Block Diagram of Test Setup

Test Setup



3.3.RF EXPOSURE Limits

According to § 1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines. According to § 1.1310 and § 2.1093 RF exposure is calculated. According KDB680106 D01v02: RF Exposure Wireless Charging Apps v02.

3.4. Operating Condition of EUT

- (1) Setup the EUT as shown as Section 3.2.
- (2) Turn on the power of equipment.
- (3) Let the EUT work in test mode.

3.5.Test Procedure

- (1) The RF exposure test was performed on 360 degree turn table in anechoic chamber.
- (2) The measurement probe was placed at test distance (10cm) which is between the edge of the charger and the geometric centre of probe.
- (3) The turn table was rotated 360d degree to search of highest strength.
- (4) The highest emission level was recorded and compared with limit as soon as measurement of each points (A, B, C, D, E) were completed.
- (5) The EUT were measured according to the dictates of KDB 680106D01v02.

3.6. Conducted Disturbance at Mains Terminals Test Results

For Full load mode:

E-Filed Strength at 10 cm from the edges surrounding the EUT (V/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(V/m)	(V/m)
0.120-0.205	1.23	1.16	1.24	1.33	1.21	184.2	614

H-Filed Strength at 10 cm from the edges surrounding the EUT (A/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(A/m)	(V/m)
0.120-0.205	0.21	0.23	0.19	0.17	0.18	0.489	1.63

For Half Load for wrist band mode:

E-Filed Strength at 10 cm from the edges surrounding the EUT (V/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(V/m)	(V/m)
0.120-0.205	1.19	1.16	1.22	1.26	1.17	184.2	614

H-Filed Strength at 10 cm from the edges surrounding the EUT (A/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	С	D	Е	(A/m)	(V/m)
0.120-0.205	0.19	0.21	0.17	0.17	0.16	0.489	1.63

For Half Load for shoepod mode:

E-Filed Strength at 10 cm from the edges surrounding the EUT (V/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	E	(V/m)	(V/m)
0.120-0.205	1.18	1.16	1.19	1.22	1.14	184.2	614

H-Filed Strength at 10 cm from the edges surrounding the EUT (A/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(A/m)	(V/m)
0.120-0.205	0.20	0.21	0.18	0.18	0.16	0.489	1.63

For No load mode:

E-Filed Strength at 10 cm from the edges surrounding the EUT (V/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(V/m)	(V/m)
0.120-0.205	1.18	1.16	1.17	1.15	1.13	184.2	614

H-Filed Strength at 10 cm from the edges surrounding the EUT (A/m)

Frequency	Test	Test	Test	Test	Test	Reference	Limits
Range	Position	Position	Position	Position	Position	Limit	Test
(MHz)	A	В	C	D	Е	(A/m)	(V/m)
0.120-0.205	0.19	0.20	0.16	0.17	0.15	0.489	1.63

4. PHOTOGRAPH OF TEST SETUP

For Full load mode



For Half Load for wrist band mode





For No load mode



----END OF REPORT----